

Search Notes



Application/Control No.

10/782,497

Examiner

Hiep T. Nguyen

Applicant(s)/Patent under Reexamination

CHIANG ET AL.

Art Unit

2187

SEARCHED

Class	Subclass	Date	Examiner
711	202	2/21/06	HW
	203	} Text search using EAST	
	206		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
EAST search his. is attached	2/21/06	HW
NPL search using terms similar to EAST search	↓	↓